


<b>Search Notes</b>  	<b>Application/Control No.</b>  10567082	<b>Applicant(s)/Patent Under Reexamination</b>  NISHI ET AL
	<b>Examiner</b>  Le, H. T	<b>Art Unit</b>  1773

SEARCHED			
Class	Subclass	Date	Examiner
428	402	9/17/08	hl
423	334	9/17/08	hl
502	240,407	9/17/08	hl

SEARCH NOTES			
Search Notes		Date	Examiner
WEST		9/17/07	HL
Continuation & common inventor searched (eDAN)		9/17/07	hl
WEST (updated)		9/17/08	hl

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
428	402	9/17/08	hl
423	335	9/17/08	hl
502	240,407	9/17/08	hl

	/H. T. L./ Primary Examiner.Art Unit 1794
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